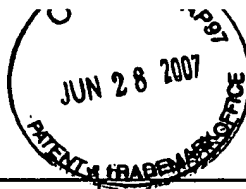
Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 127425		APPLICATION NO. 10/572,904	
INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANT(S) Tomohiro SHINAGAWA et al.			
				FILING DATE March 21, 2006		GROUP 1745	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
/HA/	1	2003/0168023 A1	09/11/2003	Anderson et al.			
/HA/	2	4,318,369	03/09/1982	Cronyn			
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Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
/HA/	3	DE 199 31 104 A1	01/11/2001	GERMANY			
/HA/	4	EP 1 236 679 A2	09/04/2002	EUROPE			
/HA/	5	WO 03/042521 A2	05/22/2003	WIPO			
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Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER				DATE CONSIDERED			
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Date: July 26, 2007

Sheet 1 of 1Form PTO-1449  
(REV. 1/06)US Dept. of Commerce  
PATENT & TRADEMARK OFFICEATTY DOCKET NO.  
127425APPLICATION NO.  
10/572,904

## INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANTS  
Tomohiro SHINAGAWA et al.FILING DATE  
March 21, 2006GROUP  
1745

## U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name

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/HA/	1.	JP-A-2000-291499	10/17/2000	JAPAN	X	X

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Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

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01/08/2008

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Date: June 28 2007

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 127425		APPLICATION NO. New U.S. National Stage of PCT/JP2004/015104	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANTS Tomohiro SHINAGAWA et al.			
				FILING DATE March 21, 2006			

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/HA/	1.	US 5,275,000	1/4/1994	COFFINBERRY ET AL.
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/HA/	4.	JP A 2000-297706	10/24/2000	JAPAN	X	X
/HA/	5.	JP A 2002-255503	9/11/2002	JAPAN	X	X
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/HA/	11.	JP A 2003-184667	7/3/2003	JAPAN	X	X
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Date: March 21, 2006